

Notice of References Cited	Application/Control No. 10/715,390	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner Adolf Berhane	Art Unit 2838	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,986,067	01-2006	Odaohhara et al.	713/320
	B	US-			
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	D	US-			
	E	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	JP 2000308257 A	11-2000	Japan	KONO et al.	
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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